VNS3NV04D-E

OMNIFET II
fully autoprotected Power MOSFET

Features

Max On-State resistance (per ch.)	R_{ON}	120mΩ
Current limitation (typ)	I_{LIMH}	3.5A
Drain-Source clamp voltage	V_{CLAMP}	40V

- Linear current limitation
- Thermal shut down
- Short circuit protection
- Integrated clamp
- Low current drawn from input pin
- Diagnostic feedback through input pin
- Esd protection
- Direct access to the gate of the power mosfet (analog driving)
- Compatible with standard power mosfet

SO-8
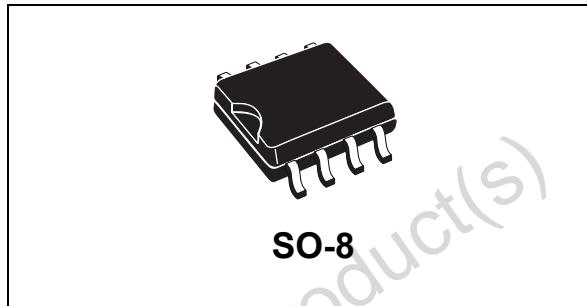
Description

The VNS3NV04D-E is a device formed by two monolithic OMNIFET II chips housed in a standard SO-8 package. The OMNIFET II are designed in STMicroelectronics VIPower M0-3 Technology: they are intended for replacement of standard Power MOSFETS from DC up to 50KHz applications. Built in thermal shutdown, linear current limitation and overvoltage clamp protects the chip in harsh environments.

Fault feedback can be detected by monitoring the voltage at the input pin.

Table 1. Device summary

Package	Tube	Tape and Reel
SO-8	VNS3NV04D-E	VNS3NV04DTR-E

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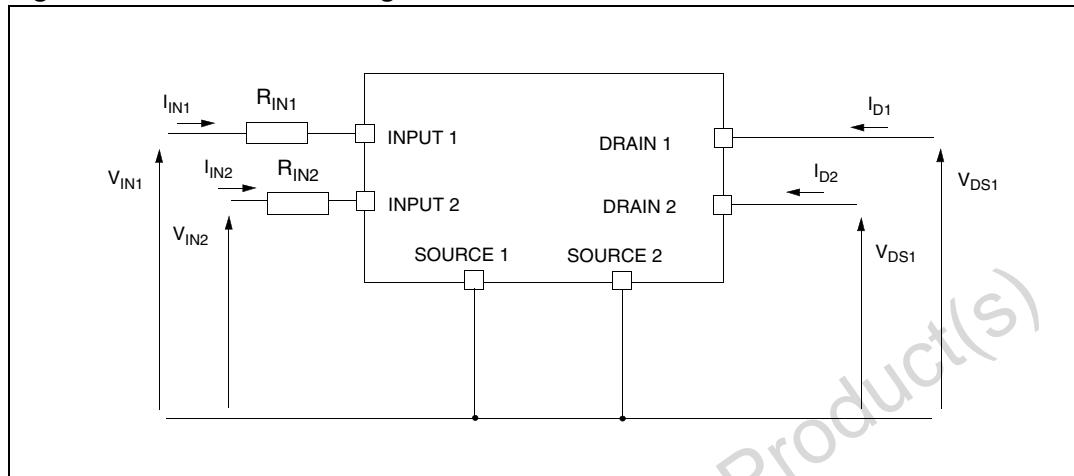
2.1 Absolute maximum ratings

Stressing the device above the rating listed in the "Absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to Absolute maximum rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE program and other relevant quality document.

Table 2.   Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DSn}	Drain-Source Voltage (V_{INn}=0V)	Internally clamped	V
V_{INn}	Input voltage	Internally clamped	V
I_{INn}	Input current	+/-20	mA
$R_{IN\ MINn}$	Minimum input series impedance	220	Ω
I_{Dn}	Drain current	Internally limited	A
I_{Rn}	Reverse DC output current	-5.5	A
V_{ESD1}	Electrostatic discharge (R=1.5KΩ, C=100pF)	4000	V
V_{ESD2}	Electrostatic discharge on output pins only (R=330Ω, C=150pF)	16500	V
P_{tot}	Total dissipation at T_c=25°C	4	Ω
T_j	Operating junction temperature	Internally limited	°C
T_c	Case operating temperature	Internally limited	°C
T_{stg}	Storage temperature	-55 to 150	°C

2.2 Thermal data

Table 3.   Thermal data

Symbol	Parameter	Max value	Unit
$R_{thj\text{-}lead}$	Thermal resistance junction-lead (per channel)	30	°C/W
$R_{thj\text{-}amb}$	Thermal resistance junction-ambient	80[1]	°C/W

1. When mounted on a standard single-sided FR4 board with 50mm^2 of Cu (at least 35 μm thick) connected to all DRAIN pins of the relative channel

2.3 Electrical characteristics

Values specified in this section are for -40°C< T_j <150°C, unless otherwise stated.

Table 4.   Off

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{CLAMP}	Drain-Source clamp voltage	V_{IN}=0V; I_D=1.5A	40	45	55	V
V_{CLTH}	Drain-Source clamp threshold voltage	V_{IN}=0V; I_D=2mA	36			V
V_{INTH}	Input threshold voltage	V_{DS}=V_{IN}; I_D=1mA	0.5		2.5	V
I_{ISS}	Supply current from input pin	V_{DS}=0V; V_{IN}=5V		100	150	μA
V_{INCL}	Input-Source clamp voltage	I_{IN}=1mA I_{IN}=-1mA	6 -1.0	6.8	8 -0.3	V
I_{DSS}	Zero input voltage drain current (V_{IN}=0V)	V_{DS}=13V; V_{IN}=0V; T_j=25°C V_{DS}=25V; V_{IN}=0V			30 75	μA

Table 5.   On

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$R_{DS(on)}$	Static Drain-Source On resistance	V_{IN}=5V; I_D=1.5A; T_j=25°C V_{IN}=5V; I_D=1.5A			120 240	mΩ

Electrical characteristics (continued) (T_j=25°C, unless otherwise specified)

Table 6.   Dynamic

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
g_{fs} [1]	Forward transconductance	V_{DD}=13V; I_D=1.5A		5.0		S
C_{OSS}	Output capacitance	V_{DS}=13V; f=1MHz; V_{IN}=0V		150		pF

Table 7.   Switching

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	V_{DD}=15V; I_D=1.5A V_{gen}=5V; R_{gen}=$R_{IN\ MIN}$=220Ω (see *Figure 4*)		90	300	ns
t_r	Rise Time			250	750	ns
$t_{d(off)}$	Turn-off delay time			450	1350	ns
t_f	Fall time			250	750	ns
$t_{d(on)}$	Turn-on delay time	V_{DD}=15V; I_D=1.5A V_{gen}=5V; R_{gen}=2.2 KΩ (see *Figure 4*)		0.45	1.35	μs
t_r	Rise time			2.5	7.5	μs
$t_{d(off)}$	Turn-off delay time			3.3	10.0	μs
t_f	Fall time			2.0	6.0	μs
$(dI/dt)_{on}$	Turn-on current slope	V_{DD}=15V; I_D=1.5A V_{gen}=5V; R_{gen}=$R_{IN\ MIN}$=220Ω		4.7		A/μs
Q_i	Total input charge	V_{DD}=12V; I_D=1.5A; V_{IN}=5V I_{gen}=2.13mA (see *Figure 7*)		8.5		nC

Table 8.   Source Drain diode

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{SD}[1]	Forward On voltage	I_{SD}=1.5A; V_{IN}=0V		0.8		V
t_{rr}	Reverse recovery time	I_{SD}=1.5A; dI/dt=12A/μs V_{DD}=30V; L=200μH (see *Figure 5*)		107		ns
Q_{rr}	Reverse recovery charge			37		μC
I_{RRM}	Reverse recovery current			0.7		A

1.   Pulsed: Pulse duration = 300μs, duty cycle 1.5%

Table 9. Protections (-40°C < T_j < 150°C, unless otherwise specified)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
I_{lim}	Drain current limit	V_{IN}=5V; V_{DS}=13V	3.5	5	7	A
t_{dlim}	Step response current limit	V_{IN}=5V; V_{DS}=13V		10		μs
T_{jsh}	Overtemperature shutdown		150	175	200	°C
T_{jrs}	Overtemperature reset		135			°C
I_{gf}	Fault sink current	V_{IN}=5V; V_{DS}=13V; T_j=T_{jsh}	10	15	20	mA
E_{as}	Single pulse avalanche energy	Starting T_j=25°C; V_{DD}=24V V_{IN}=5V R_{gen}=$R_{IN\ MIN}$=220Ω; L=24mH (see *Figure 6* and *Figure 8*)	100			mJ

Figure 4. Switching time test circuit for resistive load
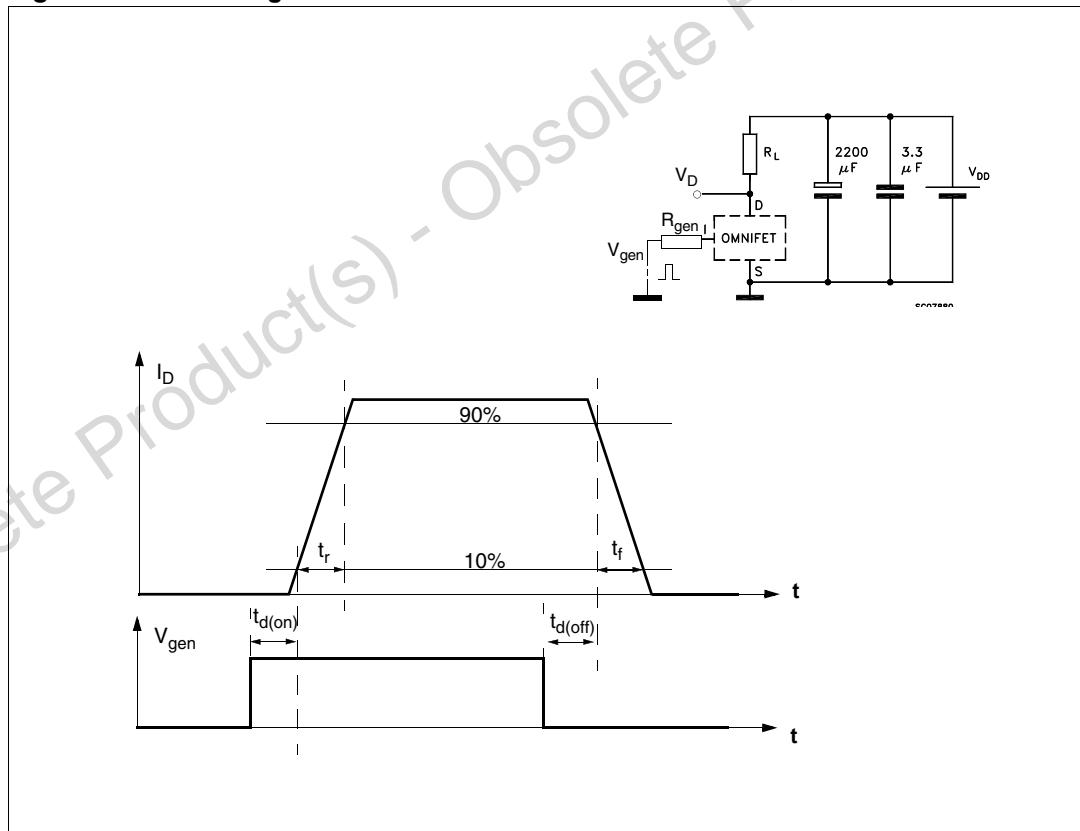
Figure 5.   Test circuit for diode recovery times
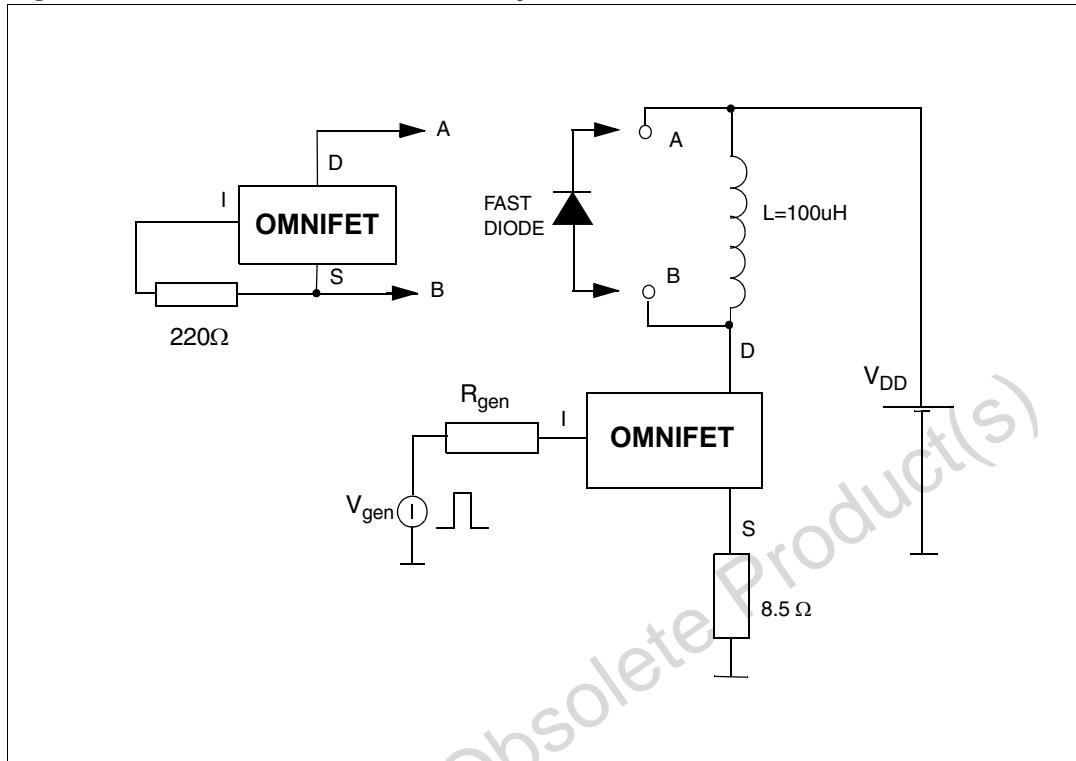
Figure 6.   Unclamped inductive load test circuits
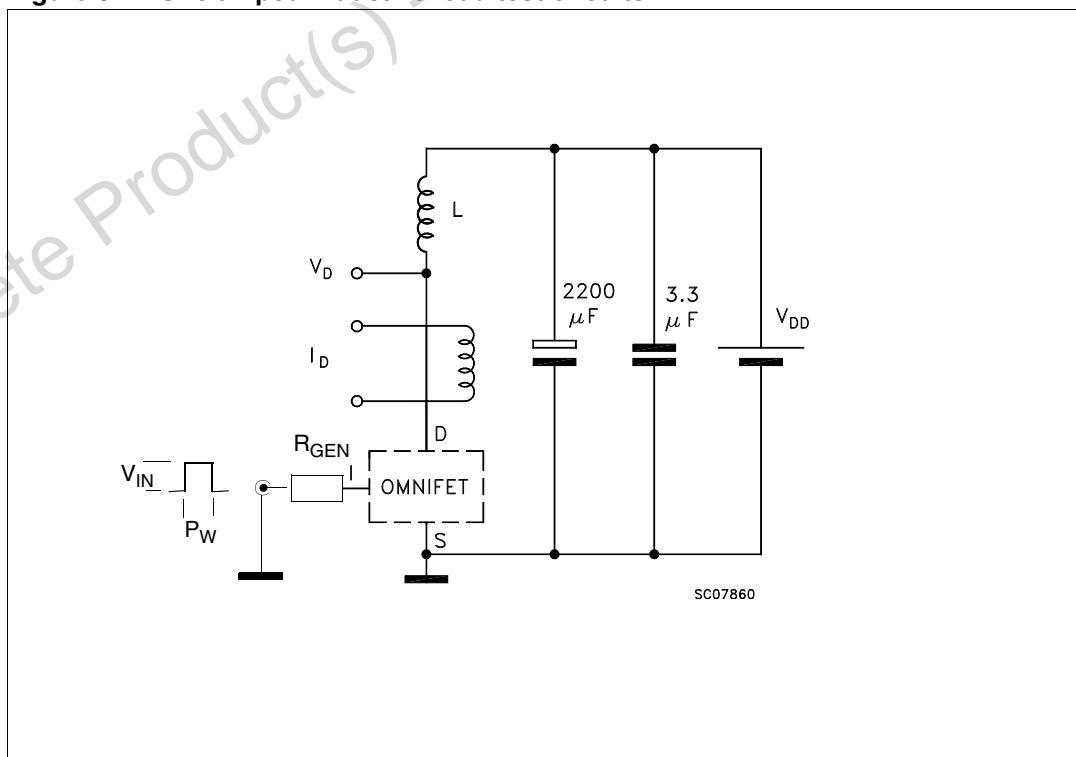
Figure 7.   Input charge test circuit
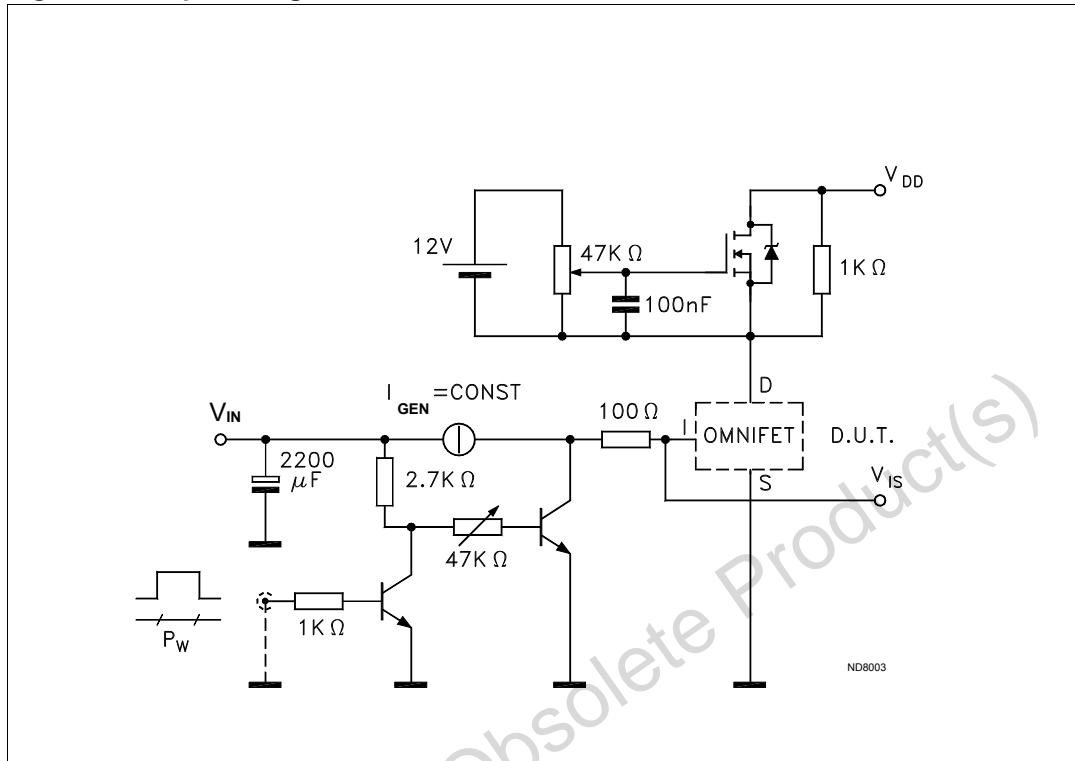

Figure 8.   Unclamped inductive waveforms
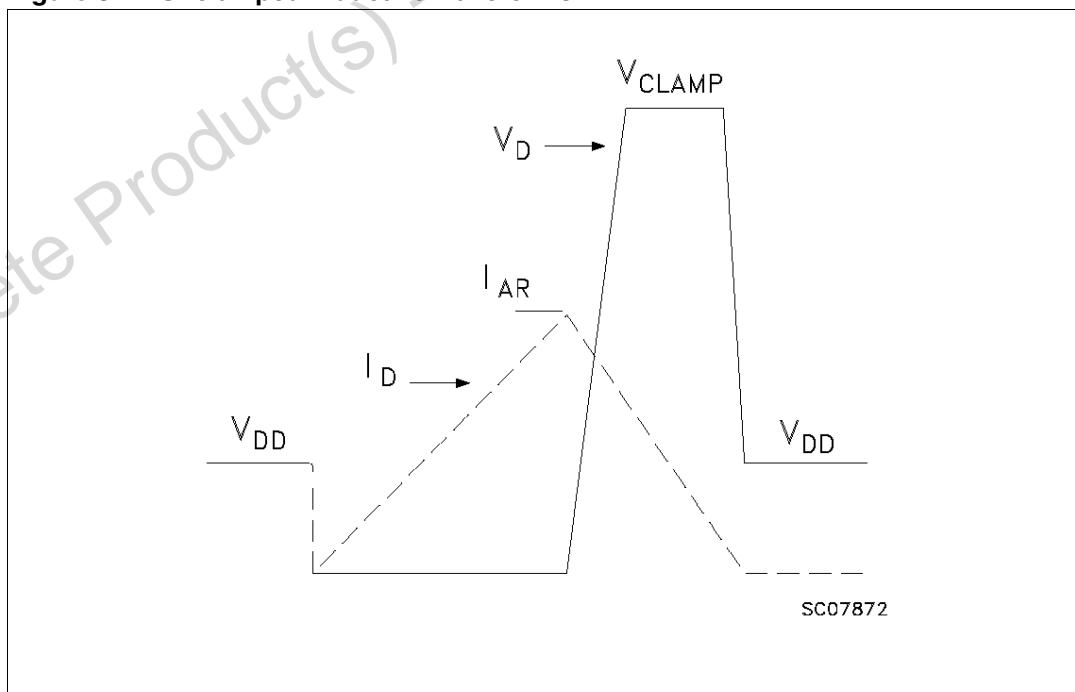
2.4 Electrical characteristics curves

**Figure 9. Source-Drain diode forward characteristics**
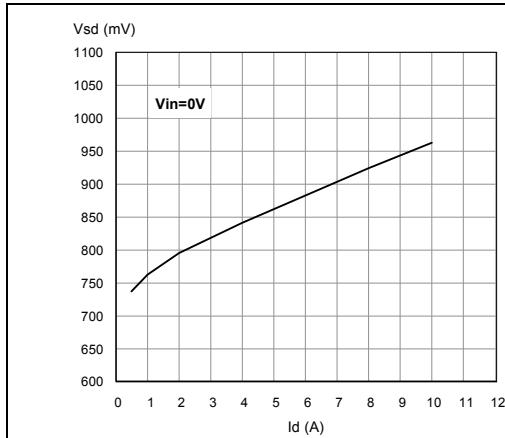
**Figure 10. Static Drain-Source On resistance**
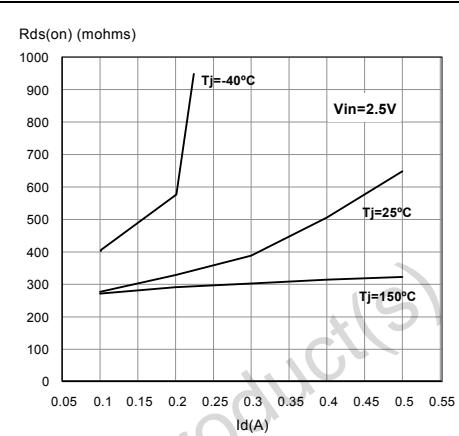
Figure 11. Derating curve
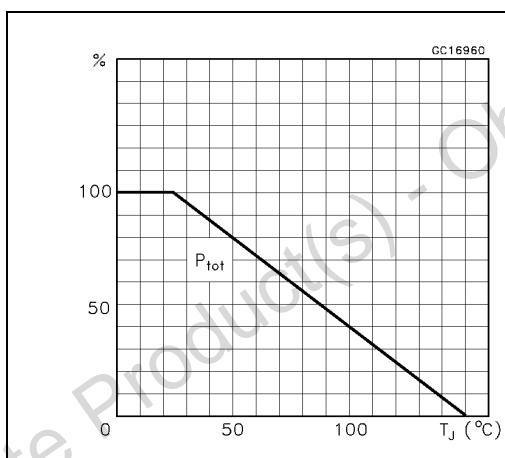
Figure 12. Static Drain-Source On resistance vs. Input voltage
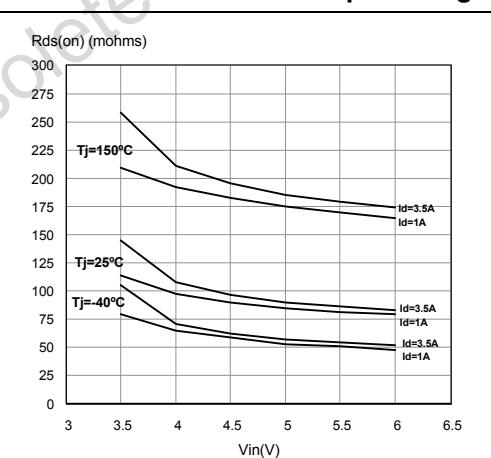
Figure 13. Static Drain-Source On resistance Vs. Input voltage
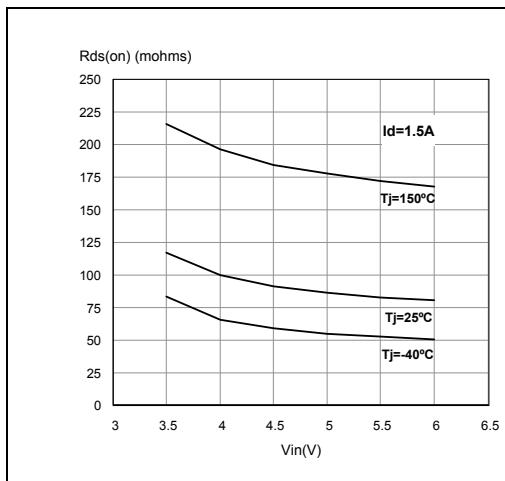
Figure 14. Transconductance
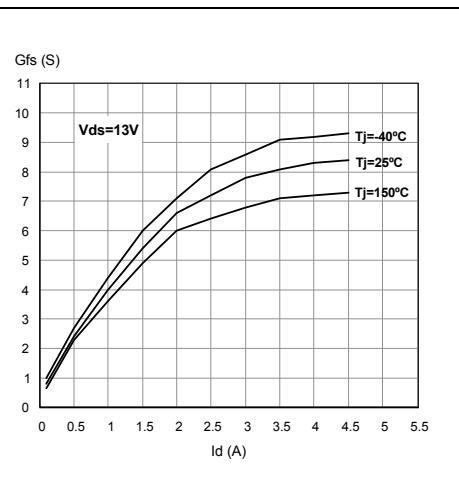
Figure 15. Static Drain-Source On resistance Vs. Id
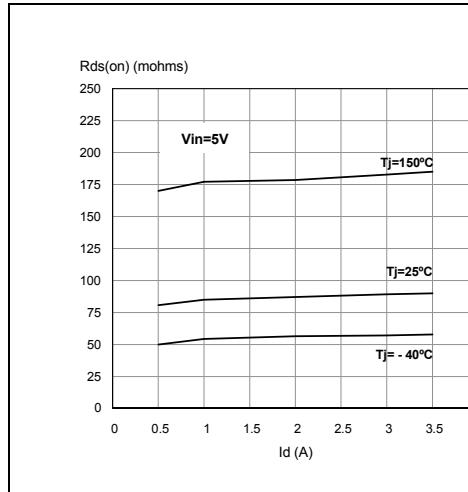
Figure 16. Transfer characteristics
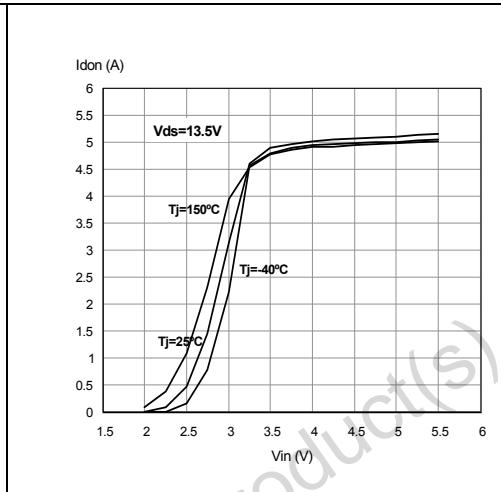
Figure 17. Turn On current slope
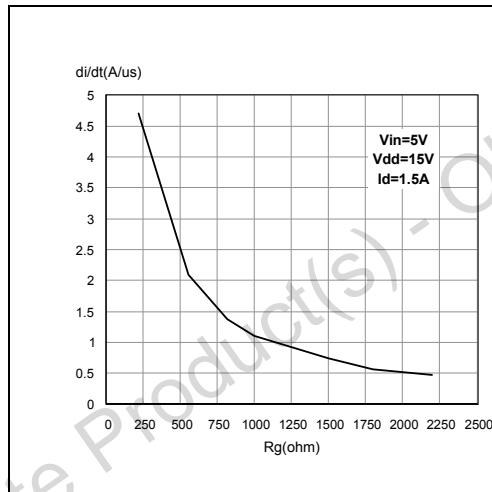
Figure 18. Turn On current slope
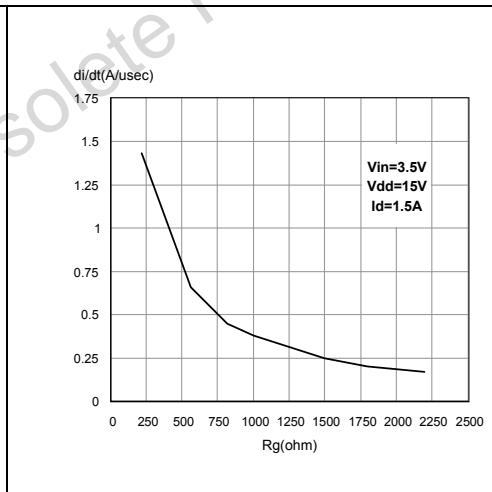
Figure 19. Input voltage Vs. Input charge
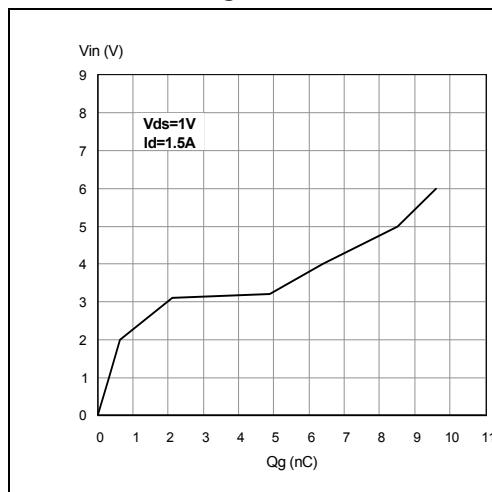
Figure 20. Turn off Drain source voltage slope
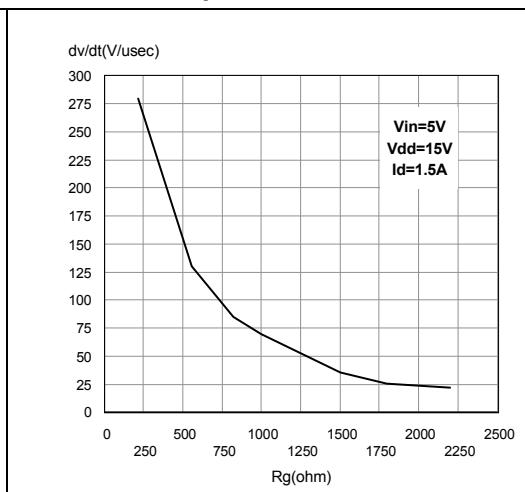
Figure 21. Turn off Drain-Source voltage slope

Figure 22. Capacitance variations
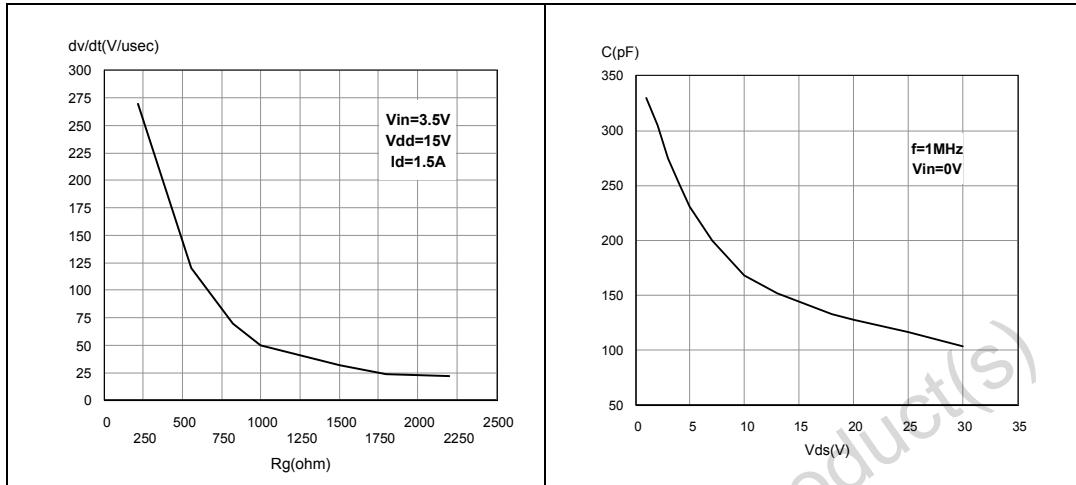
Figure 23. Switching time resistive load

Figure 24. Switching time resistive load
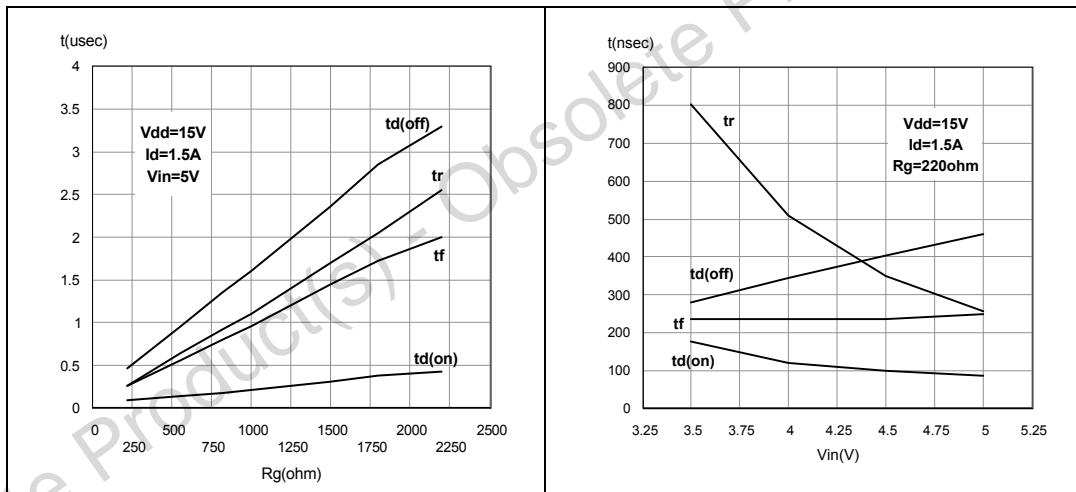
Figure 25. Output characteristics

Figure 26. Normalized On resistance Vs. temperature
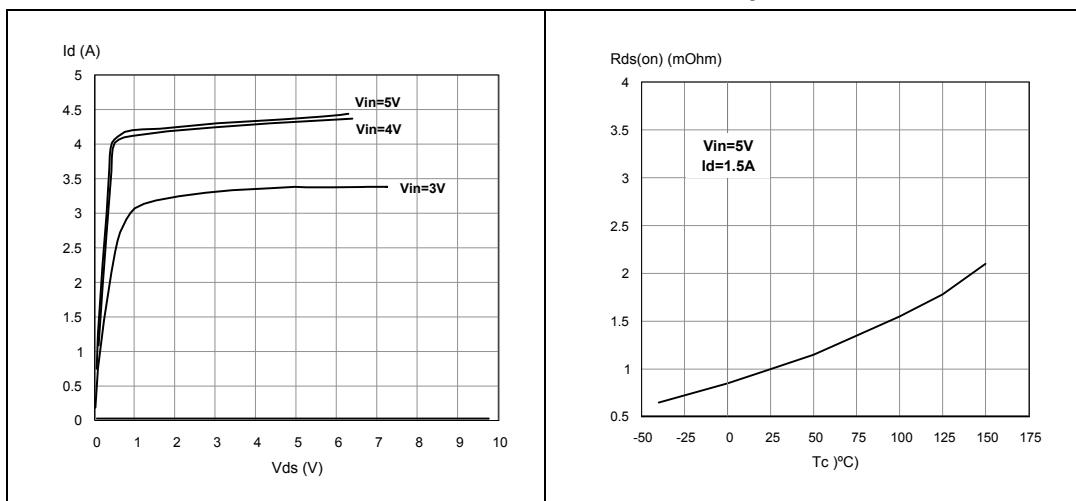
Figure 27. Normalized Input threshold voltage Vs. temperature
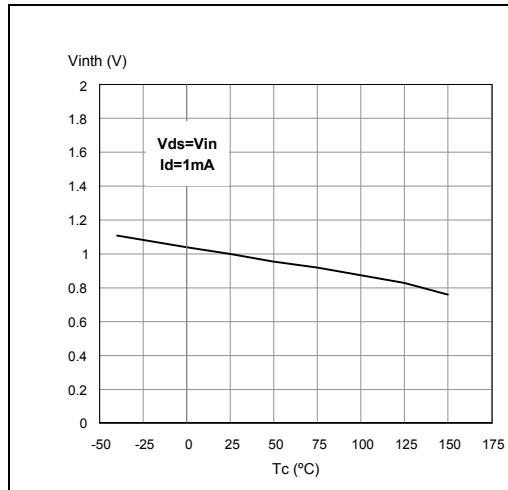
Figure 28. Normalized current limit Vs. junction temperature
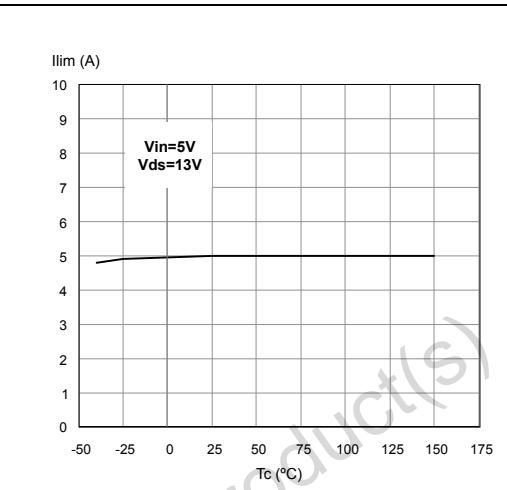
Figure 29. Step response current limit
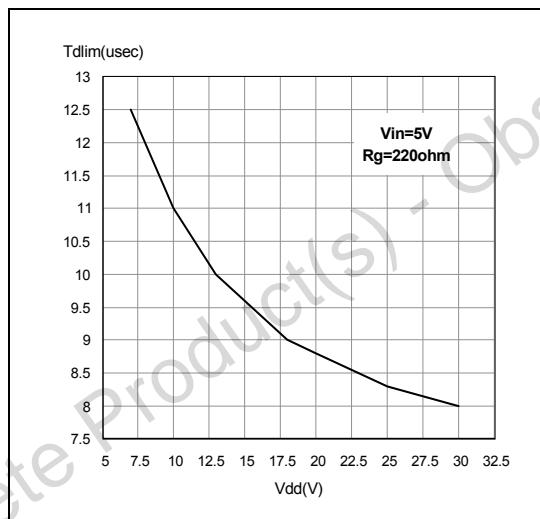
3 Protection features

During normal operation, the INPUT pin is electrically connected to the gate of the internal power MOSFET through a low impedance path.

The device then behaves like a standard power MOSFET and can be used as a switch from DC up to 50KHz. The only difference from the user's standpoint is that a small DC current I_{ISS} (typ. 100μA) flows into the INPUT pin in order to supply the internal circuitry.

The device integrates:

3.1 Overvoltage clamp protection

Internally set at 45V, along with the rugged avalanche characteristics of the Power MOSFET stage give this device unrivalled ruggedness and energy handling capability. This feature is mainly important when driving inductive loads.

3.2 Linear current limiter circuit

Limits the drain current I_D to I_{lim} whatever the INPUT pin voltages. When the current limiter is active, the device operates in the linear region, so power dissipation may exceed the capability of the heatsink. Both case and junction temperatures increase, and if this phase lasts long enough, junction temperature may reach the overtemperature threshold T_{jsh}.

3.3 Overtemperature and short circuit protection

These are based on sensing the chip temperature and are not dependent on the input voltage. The location of the sensing element on the chip in the power stage area ensures fast, accurate detection of the junction temperature. Overtemperature cutout occurs in the range 150 to 190 °C, a typical value being 170 °C. The device is automatically restarted when the chip temperature falls of about 15°C below shut-down temperature.

3.4 Status feedback

In the case of an overtemperature fault condition ($T_j > T_{jsh}$), the device tries to sink a diagnostic current I_{gf} through the INPUT pin in order to indicate fault condition. If driven from a low impedance source, this current may be used in order to warn the control circuit of a device shutdown. If the drive impedance is high enough so that the INPUT pin driver is not able to supply the current I_{gf}, the INPUT pin will fall to 0V. **This will not however affect the device operation: no requirement is put on the current capability of the INPUT pin driver except to be able to supply the normal operation drive current I_{ISS}.**

Additional features of this device are ESD protection according to the Human Body model and the ability to be driven from a TTL Logic circuit.

4 Package and packing information

4.1 ECOPACK® packages

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second-level interconnect. The category of Second-Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label.
ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

4.2 SO-8 Package mechanical data

Figure 30. SO-8 Package mechanical data & package outline

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.750			0.0689
A1	0.100		0.250	0.0039		0.0098
A2	1.250			0.0492		
b	0.280		0.480	0.0110		0.0189
c	0.170		0.230	0.0067		0.0091
D (1)	4.800	4.900	5.000	0.1890	0.1929	0.1969
E	5.800	6.000	6.200	0.2283	0.2362	0.2441
E1(2)	3.800	3.900	4.000	0.1496	0.1535	0.1575
e		1.270			0.0500	
h	0.250		0.500	0.0098		0.0197
L	0.400		1.270	0.0157		0.0500
L1		1.040			0.0409	
k	0°		8°	0°		8°
ccc			0.100			0.0039

Notes: 1. Dimensions D does not include mold flash,
protrusions or gate burrs.
Mold flash, potrusions or gate burrs shall not
exceed 0.15mm in total (both side).
2. Dimension "E1" does not include interlead flash
or protrusions. Interlead flash or protrusions shall
not exceed 0.25mm per side.

**OUTLINE AND
MECHANICAL DATA**

SO-8

0016023 D

4.3 SO-8 Packing information

Figure 31. SO-8 Tube shipment (no suffix)

Base Q.ty	100
Bulk Q.ty	2000
Tube length (± 0.5)	532
A	3.2
B	6
C (± 0.1)	0.6

All dimensions are in mm.
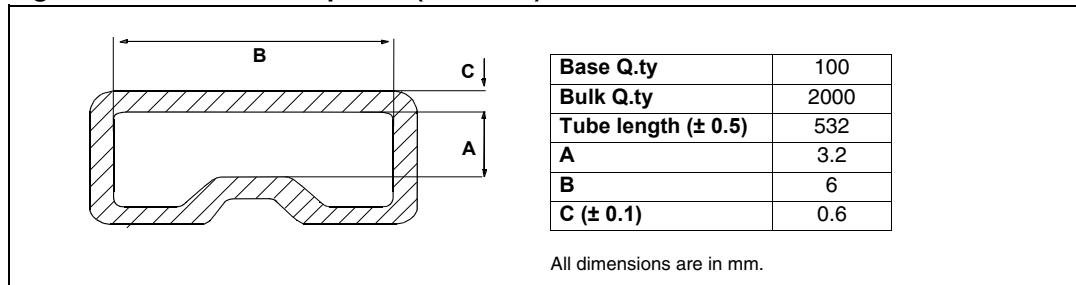
Figure 32. SO-8 Tape and reel shipment (suffix "TR")

REEL DIMENSIONS

Base Q.ty	2500
Bulk Q.ty	2500
A (max)	330
B (min)	1.5
C (± 0.2)	13
F	20.2
G (+ 2 / -0)	12.4
N (min)	60
T (max)	18.4

All dimensions are in mm.

TAPE DIMENSIONS

According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb. 1986

Tape width	W	12
Tape Hole Spacing	P0 (± 0.1)	4
Component Spacing	P	8
Hole Diameter	D (± 0.1/-0)	1.5
Hole Diameter	D1 (min)	1.5
Hole Position	F (± 0.05)	5.5
Compartment Depth	K (max)	4.5
Hole Spacing	P1 (± 0.1)	2

All dimensions are in mm.

5 Revision history

Table 10.   Document revision history

Date	Revision	Changes
28-Oct-2005	1	Initial release.
25-Jun-2007	2	Document reformatted and converted into new ST template. *Table 4: Off* - I_{DSS} unit corrected
25-Sep-2013	3	Updated disclaimer.

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